Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination | WANG ET AL. | Examiner | Art Unit | Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,317,195	05-1994	Ishikawa et al.	257/787
	В	US-5,536,584	07-1996	Sotokawa et al.	428/458
	С	US-5,536,970	07-1996	Higashi et al.	257/676
	D	US-5,561,329	10-1996	Mine et al.	257/788
	E	US-5,729,050	03-1998	Kim, Jin Sung	257/667
	F	US-5,888,849	03-1999	Johnson, Eric Arthur	438/126
	G	US-6,087,006	07-2000	Tanaka et al.	428/411.1
	Н	US-6,528,722	03-2003	Huang et al.	174/52.2
	ı	US-6,818,968	11-2004	Cheah, Eng-Chew	257/666
	J	US-6,602,803	08-2003	Yew et al.	438/780
	к	US-2002/0130397	09-2002	YEW et al.	257/666
-	L	US-6,709,895	03-2004	Distefano, Thomas H.	438/115
_	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	C	
	>	
	w	
	х	

^{*}A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.